

**Search Notes**

Application/Control No.

09/758,836

Examiner

Nam V. Nguyen

Applicant(s)/Patent under  
Reexamination

MURAKAMI ET AL.

Art Unit

2612

**SEARCHED**

Class	Subclass	Date	Examiner
340	5.82	3/20/2007	NN
340	5.8-5.84	3/20/2007	NN
340	5.52-5.53	3/20/2007	NN
382	124	3/20/2007	NN
382	115	3/20/2007	NN
235	380	3/20/2007	NN
235	492	3/20/2007	NN
235	379	3/20/2007	NN
235	381	3/20/2007	NN
455	411	3/20/2007	NN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Seach East: USPAT; US-PUB; EPO; JPO; and Derwent.	3/20/2007	NN
Search Terms: biometric sensors; ic/credit card; reflected signal/wave with biometric sensors with smart card; portable dev.	3/20/2007	NN